

STF2NK60Z - STQ2NK60ZR-AP STP2NK60Z - STD2NK60Z-1

N-CHANNEL 600V - 7.2Ω - 1.4A TO-220/TO-220FP/TO-92/IPAK Zener-Protected SuperMESH™ MOSFET

Table 1: General Features

TYPE	V _{DSS}	R _{DS(on)}	I _D	Pw
STF2NK60Z	600 V	< 8 Ω	1.4 A	20
STQ2NK60ZR-AP	600 V	< 8 Ω	0.4 A	3 W
STP2NK60Z	600 V	< 8 Ω	1.4 A	45 W
STD2NK60Z-1	600 V	< 8 Ω	1.4 A	45 W

- TYPICAL $R_{DS}(on) = 7.2 \Omega$
- EXTREMELY HIGH dv/dt CAPABILITY
- ESD IMPROVED CAPABILITY
- 100% AVALANCHE TESTED
- NEW HIGH VOLTAGE BENCHMARK
- GATE CHARGE MINIMIZED

DESCRIPTION

The SuperMESH™ series is obtained through an extreme optimization of ST's well established strip-based PowerMESH™ layout. In addition to pushing on-resistance significantly down, special care is taken to ensure a very good dv/dt capability for the most demanding applications. Such series complements ST full range of high voltage MOSFETs including revolutionary MDmesh™ products.

APPLICATIONS

- LOW POWER BATTERY CHARGERS
- SWITH MODE LOW POWER SUPPLIES(SMPS)
- LOW POWER, BALLAST, CFL (COMPACT FLUORESCENT LAMPS)

Figure 1: Package

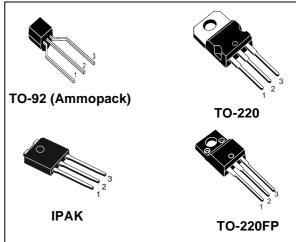


Figure 2: Internal Schematic Diagram

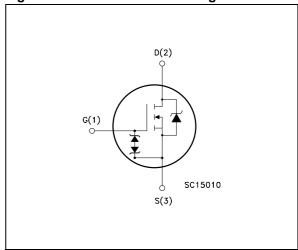


Table 2: Order Codes

Part Number	Marking	Package	Packaging
STQ2NK60ZR-AP	Q2NK60ZR	TO-92	AMMOPAK
STP2NK60Z	P2NK60Z	TO-220	TUBE
STD2NK60Z-1	D2NK60Z	IPAK	TUBE
STF2NK60Z	F2NK60Z	TO-220FP	TUBE

Rev. 5

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Table 3: Absolute Maximum ratings

Symbol	Parameter		Value		Unit
		TO-220 / IPAK	TO-92	TO-220FP	
V _{DS}	Drain-source Voltage (V _{GS} = 0)		600		V
V_{DGR}	Drain-gate Voltage ($R_{GS} = 20 \text{ k}\Omega$)		600		V
V _{GS}	Gate- source Voltage		± 30		V
ΙD	Drain Current (continuous) at T _C = 25°C	1.4 0.4 1.4 (*)		Α	
I _D	Drain Current (continuous) at T _C = 100°C	0.77	0.25	0.77 (*)	Α
I _{DM} (•)	Drain Current (pulsed)	5.6	1.6	5.6 (*)	Α
P _{TOT}	Total Dissipation at T _C = 25°C	45	3	20	W
	Derating Factor	0.36	0.025	0.16	W/°C
V _{ESD(G-S)}	Gate source ESD (HBM-C= 100pF, R=1.5kΩ)		1500		V
V _{ISO}	Insulation Withstand Voltage (DC)			2500	V
dv/dt (1)	Peak Diode Recovery voltage slope		4.5	•	V/ns
T _j T _{stg}	Operating Junction Temperature Storage Temperature	-55 to 150		°C	

^(•) Pulse width limited by safe operating area

Table 4: Thermal Data

		TO-220/IPAK TO-220FP		TO-92	Unit
Rthj-case	Thermal Resistance Junction-case Max	2.77	6.25		°C/W
Rthj-amb	Thermal Resistance Junction-ambient Max	100	100	120	°C/W
Rthj-lead	Thermal Resistance Junction-lead Max			40	°C/W
Tı	Maximum Lead Temperature For Soldering Purpose	300 260		°C	

Table 5: Avalanche Characteristics

Symbol	Parameter	Max Value	Unit
I _{AR}	Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by T_j max)	1.4	Α
E _{AS}	Single Pulse Avalanche Energy (starting $T_j = 25$ °C, $I_D = I_{AR}$, $V_{DD} = 50$ V)	90	mJ

Table 6: Gate-Source Zener Diode

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
BV _{GSO}	Gate source Breakdown Voltage	I _{gs} = ± 1 mA (Open Drain)	30			V

PROTECTION FEATURES OF GATE-TO-SOURCE ZENER DIODES

The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

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⁽¹⁾ $I_{SD} \le 1.4A$, di/dt $\le 200A/\mu s$, $V_{DD} \le V_{(BR)DSs}$, $T_j \le T_{JMAX}$. (*) Limited only by maximum temperature allowed

ELECTRICAL CHARACTERISTICS (T_{CASE} =25°C UNLESS OTHERWISE SPECIFIED)

Table 7: On/Off

Symbol	Parameter	Parameter Test Conditions		Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source Breakdown Voltage	$I_D = 1$ mA, $V_{GS} = 0$	600			V
I _{DSS}	Zero Gate Voltage Drain Current (V _{GS} = 0)	V _{DS} = Max Rating V _{DS} = Max Rating, T _C = 125 °C			1 50	μA μA
I _{GSS}	Gate-body Leakage Current (V _{DS} = 0)	V _{GS} = ± 20V			±10	μA
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 50 \mu A$	3	3.75	4.5	V
R _{DS(on)}	Static Drain-source On Resistance	V _{GS} = 10V, I _D = 0.7 A		7.2	8	Ω

Table 8: Dynamic

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
g _{fs} (1)	Forward Transconductance	V _{DS} = 15 V _, I _D = 0.7 A		1		S
C _{iss} C _{oss} C _{rss}	Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{DS} = 25V$, $f = 1$ MHz, $V_{GS} = 0$		170 27 5		pF pF pF
Coss eq. (3)	Equivalent Output Capacitance	$V_{GS} = 0V, V_{DS} = 0V \text{ to } 480V$		30		pF
t _{d(on)} t _r t _{d(off)} t _r	Turn-on Delay Time Rise Time Turn-off Delay Time Fall Time	V_{DD} = 300 V, I_D = 0.65 A, R_G = 4.7 Ω , V_{GS} = 10 V (Resistive Load see, Figure 22)		8 30 22 55		ns ns ns ns
Q _g Q _{gs} Q _{gd}	Total Gate Charge Gate-Source Charge Gate-Drain Charge	$V_{DD} = 480V, I_{D} = 1.5 A,$ $V_{GS} = 10V$ (see, Figure 24)		7.7 1.7 4	10	nC nC nC

Table 9: Source Drain Diode

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
I _{SD} I _{SDM} (2)	Source-drain Current Source-drain Current (pulsed)				1.5 6	A A
V _{SD} (1)	Forward On Voltage	I _{SD} = 1.5 A, V _{GS} = 0			1.6	V
t _{rr} Q _{rr} I _{RRM}	Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current	I_{SD} = 1.3 A, di/dt = 100 A/ μ s V_{DD} = 25V, T_j = 25°C (see test circuit, Figure 23)		250 550 4.4		ns µC A
t _{rr} Q _{rr} I _{RRM}	Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current	I_{SD} = 1.3 A, di/dt = 100 A/ μ s V_{DD} = 25V, T_j = 150°C (see test circuit, Figure 23)		300 690 4.6		ns µC A

⁽¹⁾ Pulsed: Pulse duration = 300 μs, duty cycle 1.5 %.
(2) Pulse width limited by safe operating area.
(3) C_{oss eq.} is defined as a constant equivalent capacitance giving the same charging time as Coss when VDS increases from 0 to 80% VDSS

Figure 3: Safe Operating Area For TO-220

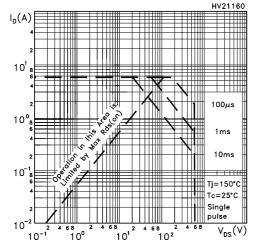


Figure 4: Safe Operating Area For IPAK

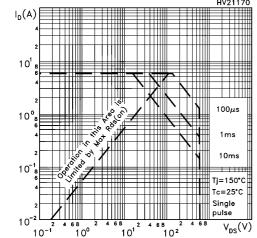


Figure 5: Safe Operating Area For TO-92

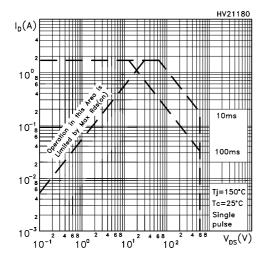


Figure 6: Thermal Impedance For TO-220

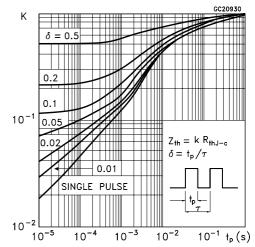


Figure 7: Thermal Impedance For IPAK

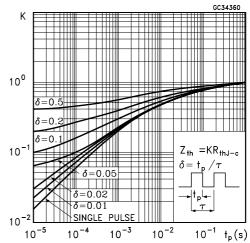


Figure 8: Thermal Impedance For TO-92

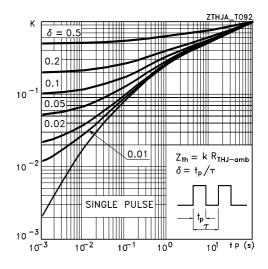


Figure 9: Safe Operating Area For TO-220FP

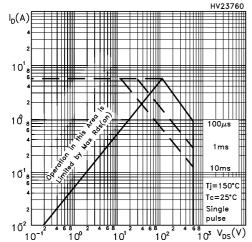


Figure 10: Output Characteristics

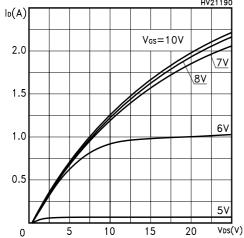


Figure 11: Transconductance

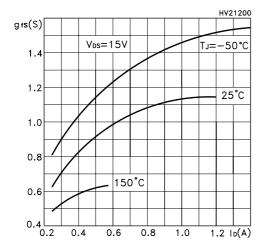


Figure 12: Thermal Impedance For TO-220FP

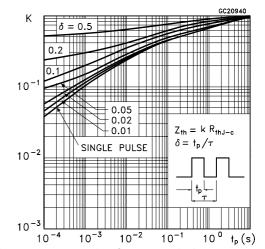


Figure 13: Transfer Characteristics

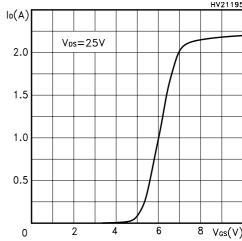
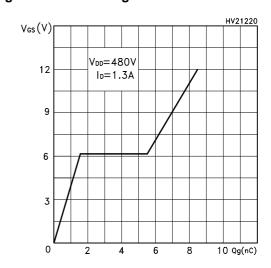


Figure 14: Gate Charge vs Gate-source Voltage



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Figure 15: Static Drain-source On Resistance

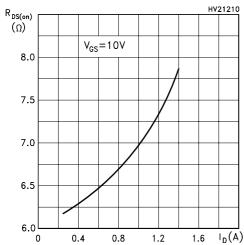


Figure 16: Capacitance Variations

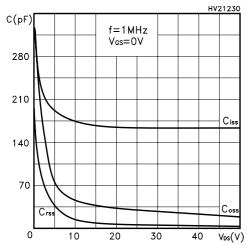


Figure 17: Normalized Gate Thereshold Voltage vs Temperature

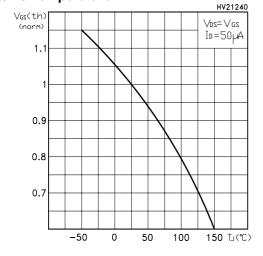


Figure 18: Source-Drain Forward Characteristics

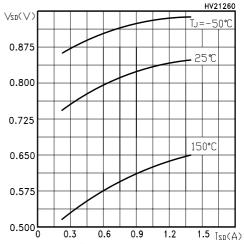


Figure 19: Maximum Avalanche Energy vs Temperature

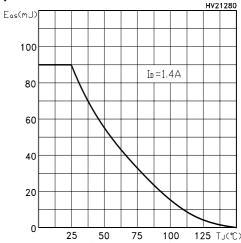
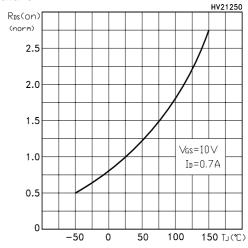


Figure 20: Normalized On Resistance vs Temperature





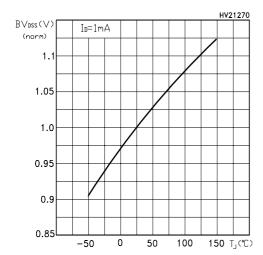


Figure 22: Switching Times Test Circuit For Resistive Load

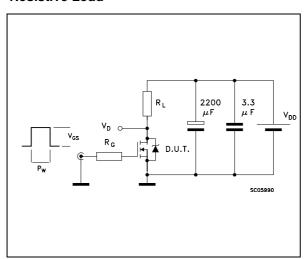


Figure 23: Test Circuit For Inductive Load Switching and Diode Recovery Times

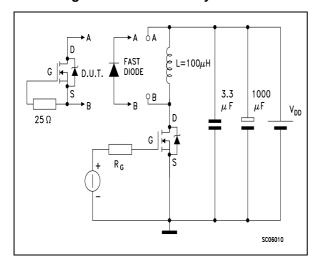
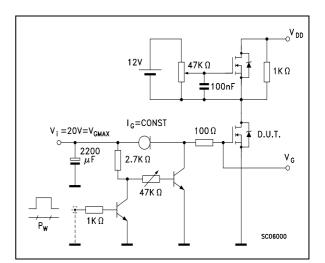


Figure 24: Gate Charge Test Circuit

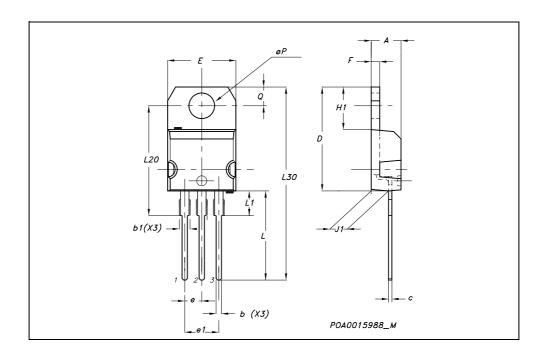


STQ2NK60ZR-AP - STP2NK60Z - STF2NK60Z - STD2NK60Z-1

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

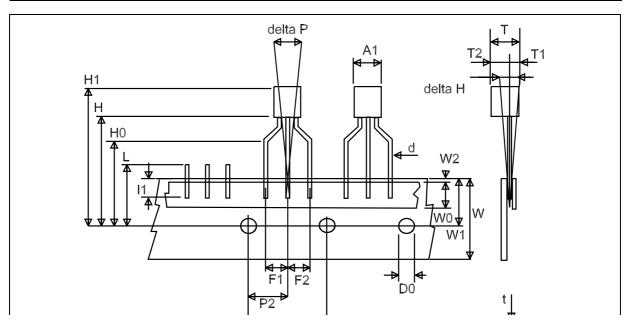
TO-220 MECHANICAL DATA

DIM		mm.			inch	
DIM.	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
Α	4.40		4.60	0.173		0.181
b	0.61		0.88	0.024		0.034
b1	1.15		1.70	0.045		0.066
С	0.49		0.70	0.019		0.027
D	15.25		15.75	0.60		0.620
Е	10		10.40	0.393		0.409
е	2.40		2.70	0.094		0.106
e1	4.95		5.15	0.194		0.202
F	1.23		1.32	0.048		0.052
H1	6.20		6.60	0.244		0.256
J1	2.40		2.72	0.094		0.107
L	13		14	0.511		0.551
L1	3.50		3.93	0.137		0.154
L20		16.40			0.645	
L30		28.90			1.137	
øΡ	3.75		3.85	0.147		0.151
Q	2.65		2.95	0.104		0.116



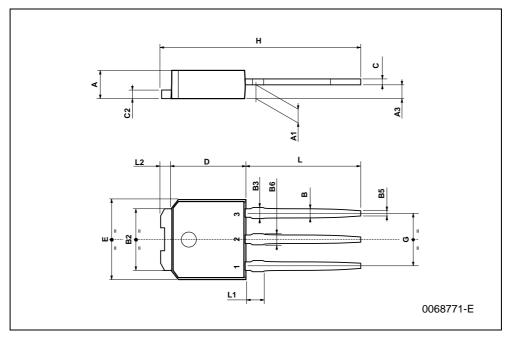
TO-92 AMMOPACK

DIM.		mm.		inch			
DIIVI.	MIN.	TYP	TYP MAX.		TYP.	MAX.	
A1	4.45		4.95	0.170		0.194	
Т	3.30		3.94	0.130		0.155	
T1			1.6			0.06	
T2			2.3			0.09	
d	0.41		0.56	0.016		0.022	
P0	12.5	12.7	12.9	0.49	0.5	0.51	
P2	5.65	6.35	7.05	0.22	0.25	0.27	
F1, F2	2.44	2.54	2.94	0.09	0.1	0.11	
delta H	-2		2	-0.08		0.08	
W	17.5	18	19	0.69	0.71	0.74	
W0	5.7	6	6.3	0.22	0.23	0.24	
W1	8.5	9	9.25	0.33	0.35	0.36	
W2			0.5			0.02	
Н	18.5		20.5	0.72		0.80	
H0	15.5	16	16.5	0.61	0.63	0.65	
H1			25			0.98	
D0	3.8	4	4.2	0.15	0.157	0.16	
t			0.9			0.035	
L			11			0.43	
I1	3			0.11			
delta P	-1		1	-0.04		0.04	



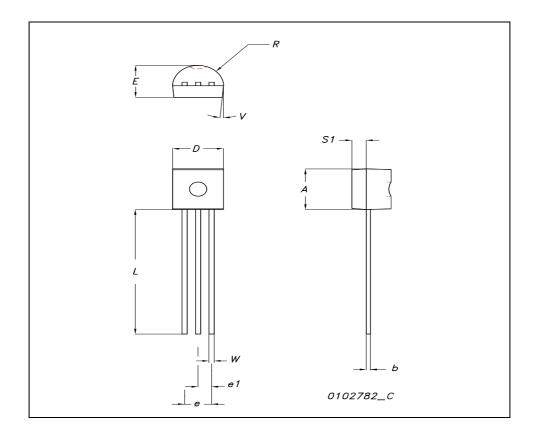
TO-251 (IPAK) MECHANICAL DATA

DIM.		mm			inch	
DIIVI.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
Α	2.2		2.4	0.086		0.094
A1	0.9		1.1	0.035		0.043
А3	0.7		1.3	0.027		0.051
В	0.64		0.9	0.025		0.031
B2	5.2		5.4	0.204		0.212
В3			0.85			0.033
B5		0.3			0.012	
B6			0.95			0.037
С	0.45		0.6	0.017		0.023
C2	0.48		0.6	0.019		0.023
D	6		6.2	0.236		0.244
Е	6.4		6.6	0.252		0.260
G	4.4		4.6	0.173		0.181
Н	15.9		16.3	0.626		0.641
L	9		9.4	0.354		0.370
L1	0.8		1.2	0.031		0.047
L2		0.8	1		0.031	0.039



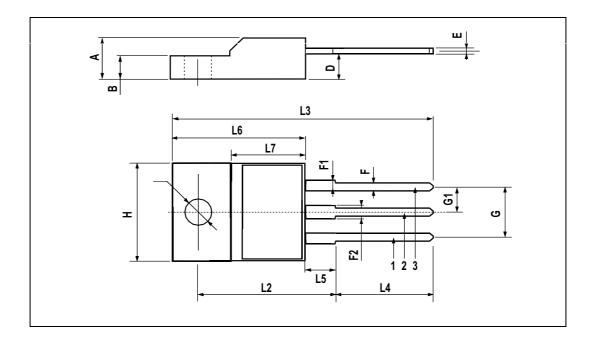
TO-92 MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
А	4.32		4.95	0.170		0.194
b	0.36		0.51	0.014		0.020
D	4.45		4.95	0.175		0.194
E	3.30		3.94	0.130		0.155
е	2.41		2.67	0.094		0.105
e1	1.14		1.40	0.044		0.055
L	12.70		15.49	0.50		0.610
R	2.16		2.41	0.085		0.094
S1	0.92		1.52	0.036		0.060
W	0.41		0.56	0.016		0.022
V		5°			5°	



TO-220FP MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
Α	4.4		4.6	0.173		0.181
В	2.5		2.7	0.098		0.106
D	2.5		2.75	0.098		0.108
Е	0.45		0.7	0.017		0.027
F	0.75		1	0.030		0.039
F1	1.15		1.7	0.045		0.067
F2	1.15		1.7	0.045		0.067
G	4.95		5.2	0.195		0.204
G1	2.4		2.7	0.094		0.106
Н	10		10.4	0.393		0.409
L2		16			0.630	
L3	28.6		30.6	1.126		1.204
L4	9.8		10.6	.0385		0.417
L5	2.9		3.6	0.114		0.141
L6	15.9		16.4	0.626		0.645
L7	9		9.3	0.354		0.366
Ø	3		3.2	0.118		0.126



STQ2NK60ZR-AP - STP2NK60Z - STF2NK60Z - STD2NK60Z-1

Table 10: Revision History

Date	Revision	Description of Changes
07-Jul-2004	3	The document change from "TARGET" to "COMPLETE"
		New stylesheet
11/Nov/2004	4	Added TO-220FP
05-Sep-2005	5	Inserted Ecopack indication

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